

# N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ Max.	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)				
80	0.0062 at V <sub>GS</sub> = 10 V	80 <sup>a</sup>	17.1 nC				

#### **FEATURES**

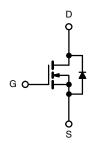
- DT-Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested



#### **APPLICATIONS**

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting





N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	80	.,		
Gate-Source Voltage	$V_{GS}$	± 20	V		
	T <sub>C</sub> = 25 °C		80 <sup>a</sup>		
Continuous Drain Current /T 150 °C\	T <sub>C</sub> = 70 °C		72		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	35 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		30 <sup>b, c</sup>	A	
Pulsed Drain Current (t = 100 μs)	I <sub>DM</sub>	320	A		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	,	80a		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	9.5 <sup>b, c</sup>	mJ	
Single Pulse Avalanche Current	1 0.1 ml l	I <sub>AS</sub>	70		
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	450		
	T <sub>C</sub> = 25 °C		295	w	
Marian and Danier Disable at land	T <sub>C</sub> = 70 °C	D	160		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	5 <sup>b</sup> , c		
	T <sub>A</sub> = 70 °C		3b, c		
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	00		
Soldering Recommendations (Peak Temperatur	_	260	°C		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	12	16	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	0.39	0.54	C/W		

#### **Notes**

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. The TO-263 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.

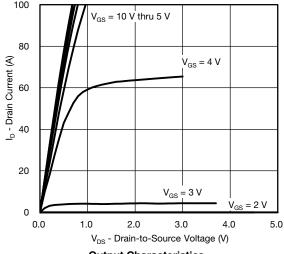


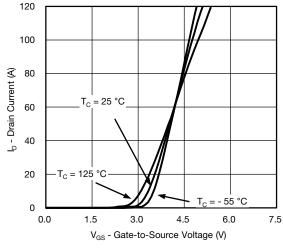
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				'		,
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			37		1400
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 6		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th</sub> )	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zova Cata Valtaga Dvain Cuwant		$V_{DS} = 65 \text{ V}, V_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 65 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	320			Α
Drain-Source On-State Resistancea	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0062	0.007	Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 20 \text{ A}$		60		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			4255		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		750		
Reverse Transfer Capacitance	C <sub>rss</sub>			66		
		$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		55	84	nC
Total Gate Charge	Qg	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		22	33	
		V <sub>DS</sub> = 50 V,V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		20	26	
Gate-Source Charge	Q <sub>gs</sub>			5.3		
Gate-Drain Charge	Q <sub>gd</sub>			7.3		
Output Charge	Q <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		61	88	
Gate Resistance	$R_g$	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$ f = 1 MHz	0.5	1.4	2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			14		
Rise Time	t <sub>r</sub>	$V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$		10		ns
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		33		
Fall Time	t <sub>f</sub>			8		
Turn-On Delay Time	t <sub>d(on)</sub>			15		115
Rise Time	t <sub>r</sub>	$V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$		13		- - -
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 6.0 \text{ V}, R_g = 1 \Omega$		34		
Fall Time	t <sub>f</sub>			8		
<b>Drain-Source Body Diode Characteristic</b>	s					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			80	A
Pulse Diode Forward Current (t = 100 μs)	I <sub>SM</sub>				320	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 5 A		0.76	1.3	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			36		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 10 A dl/dt = 100 A/vo T: = 25 °C		37		nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		20		ns
Reverse Recovery Rise Time	t <sub>b</sub>			20		

#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

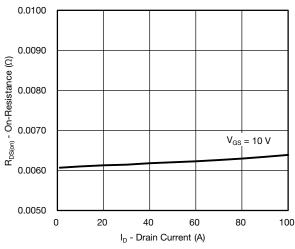
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

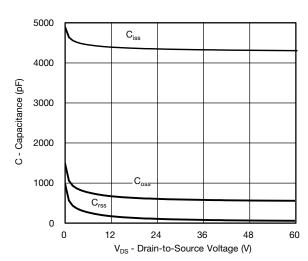






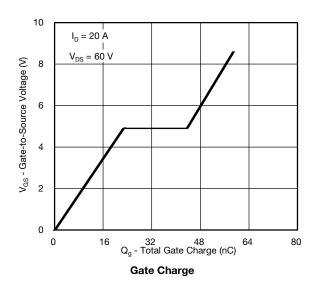


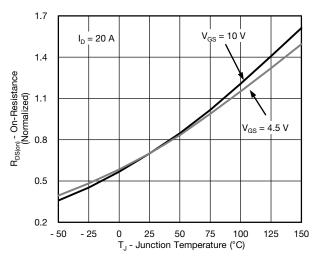




#### On-Resistance vs. Drain Current

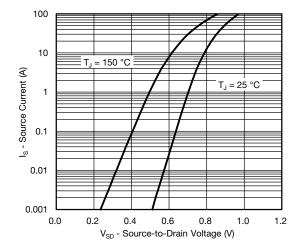
Capacitance



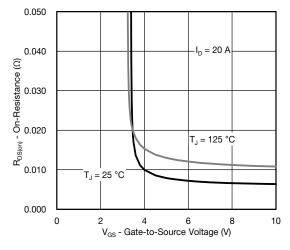


On-Resistance vs. Junction Temperature

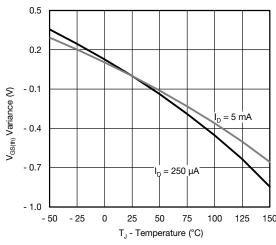




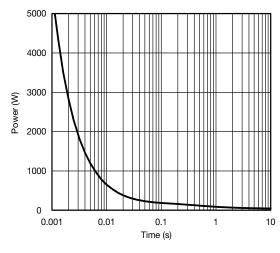
Source-Drain Diode Forward Voltage



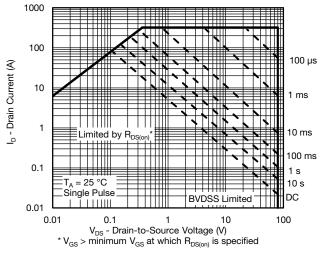
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



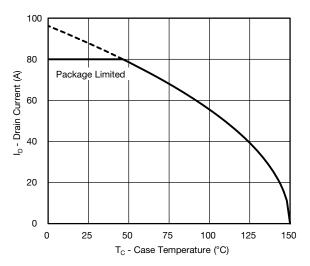
Single Pulse Power, Junction-to-Ambient



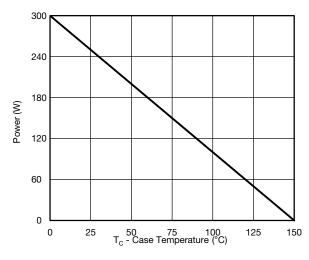
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Safe Operating Area, Junction-to-Ambient

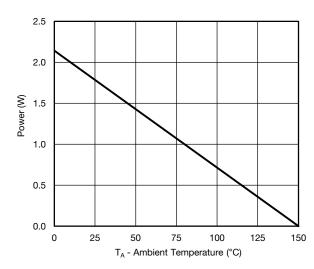




#### **Current Derating\***



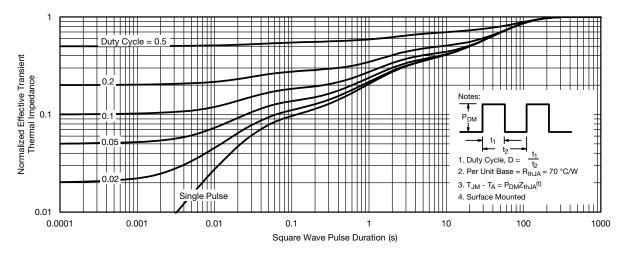




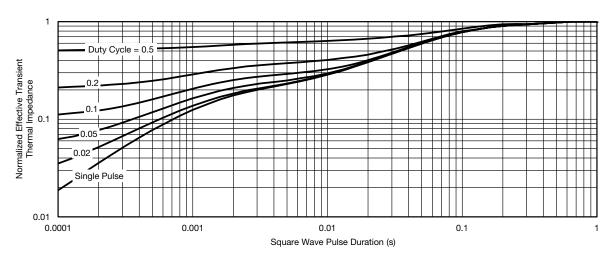
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





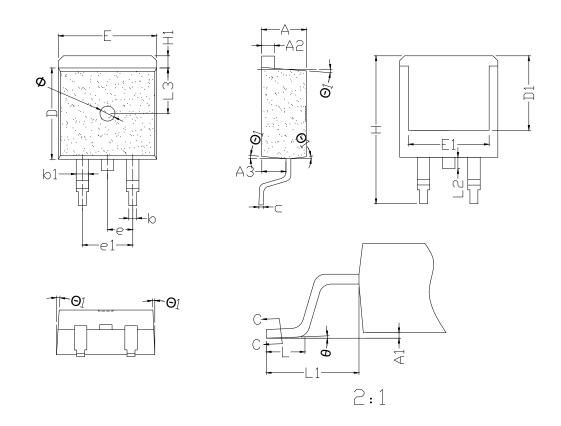
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-263 PACKAGE OUTLINE**



# COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	SYMBOL	MIN	TYP	MAX
Α	4.10	4.50	4.80	е	2.35	2.54	2.75
A1	0.00	0.10	0.30	e1	5.08REF		
A2	1.10	1.30	1.50	Н	14.50 15.15 16.0		
A3	2.15	2.50	3.10	H1	1.00	1.28	1.75
b	0.60	0.80	1.05	L	1.80	2.23	2.90
b1	1.05	1.33	1.50	L1	4.30	4.75	5.50
С	0.33	0.50	0.66	L2	1.00	1.30	1.85
D	8.40	9.20	9.60	L3	0.90	4.65	9.00
D1	7.50REF			ф	0°	2°	5°
E	9.60	10.02	10.80	φ1	2°	-	7°
E1	7.60	9.88	10.30	Φ	1.5BSC		





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